

- **Ideal for 868.30 MHz Transmitters**
- **Very Low Insertion Loss**
- **Quartz Stability**
- **Ultra Miniature Ceramic QCC8C SMD Package**
- **Complies with Directive 2002/95/EC (RoHS Compliant)**

# SR5903

ABSOLUTE MAXIMUM RATING ( $T_A=25^{\circ}\text{C}$ )		
Parameter	Rating	Unit
CW RF Power Dissipation	$P$	0
DC Voltage	$V_{bc}$	$\pm 30$
Operating Temperature Range	$T_A$	-10 ~ +60
Storage Temperature Range	$T_{stg}$	-40 ~ +85

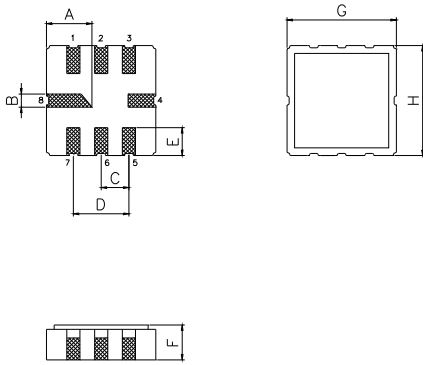
ELECTRONIC CHARACTERISTICS						
Parameter	Sym	Minimum	Typical	Maximum	Unit	
Frequency (25°C)	Nominal Frequency	$f_c$	NS	868.30	NS	MHz
	Tolerance from 868.30 MHz	$\Delta f_c$	-	-	$\pm 150$	KHz
Insertion Loss		$IL$	-	1.5	2.2	dB
Quality Factor	Unloaded Q-Value	$Q_u$	-	10,020	-	-
	50Ω Loaded Q-Value	$Q_L$	-	1,600	-	-
Temperature Stability	Turnover Temperature	$T_o$	25	-	55	°C
	Turnover Frequency	$f_o$	-	$f_c$	-	KHz
	Frequency Temperature Coefficient	$FTC$	-	0.032	-	ppm/°C <sup>2</sup>
Frequency Aging	Absolute Value during the First Year	$ f_A $	-	-	10	ppm/yr
DC Insulation Resistance Between any Two Pins		-	1.0	-	-	MΩ
RF Equivalent RLC Model	Motional Resistance	$R_M$	-	19.0	29.0	Ω
	Motional Inductance	$L_M$	-	34.9170	-	μH
	Motional Capacitance	$C_M$	-	0.96317	-	fF
	Shunt Static Capacitance	$C_o$	2.20	2.50	2.80	pF

NS = Not Specified

**Note:**

- The frequency  $f_c$  is the frequency of minimum IL with the resonator in the specified test fixture in a 50Ω test system with VSWR  $\leq 1.2:1$ .
- Unless noted otherwise, case temperature TC = +25°C±2°C.
- Frequency aging is the change in fC with time and is specified at +65°C or less. Aging may exceed the specification for prolonged temperatures above +65°C. Typically, aging is greatest the first year after manufacture, decreasing in subsequent years.
- Turnover temperature, T<sub>0</sub>, is the temperature of maximum (or turnover) frequency, f<sub>0</sub>. The nominal frequency at any case temperature, TC, may be calculated from:  $f = f_o [1 - FTC (T_o - T_C)^2]$ .
- This equivalent RLC model approximates resonator performance near the resonant frequency and is provided for reference only. The capacitance C<sub>o</sub> is the measured static (nonmotional) capacitance between input terminal and ground or output terminal and ground.
- The measurement includes case parasitic capacitance.
- Derived mathematically from one or more of the following directly measured parameters:  $f_c$ , IL, 3 dB bandwidth,  $f_c$  versus T<sub>C</sub>, and Co.
- The specifications of this device are based on the test circuit shown above and subject to change or obsolescence without notice.
- Typically, equipment utilizing this device requires emissions testing and government approval, which is the responsibility of the equipment manufacturer.
- Our liability is only assumed for the Surface Acoustic Wave (SAW) component(s) per se, not for applications, processes and circuits implemented within components or assemblies.
- For questions on technology, prices and delivery, please contact our sales offices or e-mail to sales@vanlong.com.

PACKAGE DIMENSIONS (QCC8C)



Electrical Connections

Terminals	Connection
2	Terminal 1
6	Terminal 2
4,8	Case-Ground
1,3,5,7	NC

Package Dimensions

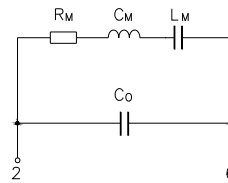
Dimensions	Nom (mm)	Dimensions	Nom (mm)
A	2.08	E	1.20
B	0.60	F	1.35
C	1.27	G	5.00
D	2.54	H	5.00

MARKING

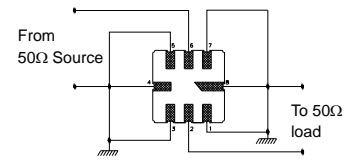


- Laser or Ink marking.
- SR5903 - Part Code
  - Date Code:  
 Y : Last digit of year  
 WW : Week No.

EQUIVALENT LC MODEL AND TEST CIRCUIT



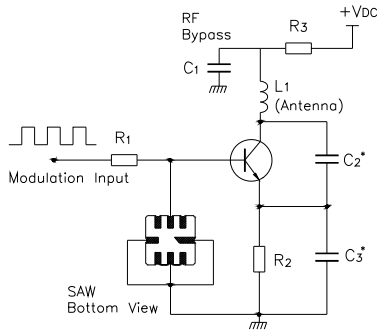
Equivalent LC Model



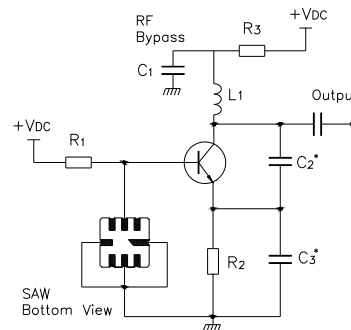
Test Circuit

TYPICAL APPLICATION CIRCUIT

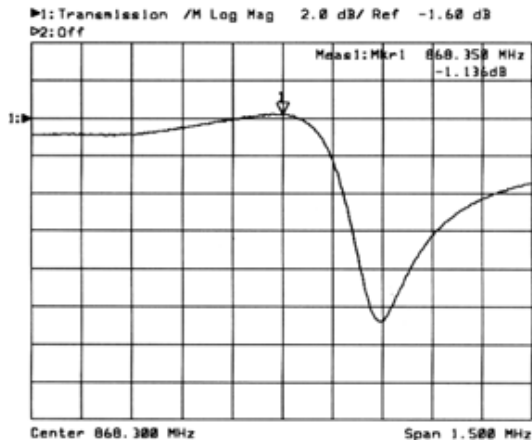
Low Power Transmitter Application



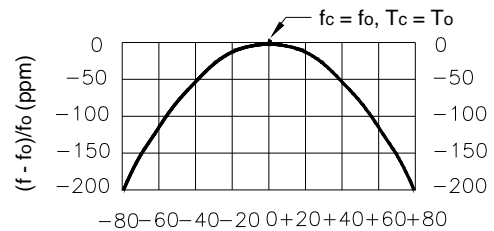
Local Oscillator Application



TYPICAL FREQUENCY RESPONSE



TEMPERATURE CHARACTERISTICS



$$\Delta T = T_c - T_o \text{ (}^\circ\text{C)}$$

The curve shown above accounts for resonator contribution only and does not include oscillator temperature characteristics.